

Notice of References Cited	Application/Control No. 10/790,728		Applicant(s)/Patent Under Reexamination HAN, CHEUL KYUNG	
	Examiner Linh T. Nguyen		Art Unit 2627	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0072233	04-2003	Naoi et al.	369/47.53
*	B	US-6,904,009	06-2005	Mashimo et al.	369/47.5
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	M	US-			

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NON-PATENT DOCUMENTS

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